

October 1997 Revised April 1999

74VCX16374

Low Voltage 16-Bit D-Type Flip-Flop with 3.6V Tolerant Inputs and Outputs

General Description

The VCX16374 contains sixteen non-inverting D-type flipflops with 3-STATE outputs and is intended for bus oriented applications. The device is byte controlled. A buffered clock (CP) and output enable $(\overline{\text{OE}})$ are common to each byte and can be shorted together for full 16-bit operation.

The 74VCX16374 is designed for low voltage (1.65V to 3.6V) $\rm V_{CC}$ applications with I/O compatibility up to 3.6V.

The 74VCX16374 is fabricated with an advanced CMOS technology to achieve high speed operation while maintaining low CMOS power dissipation.

Features

- 1.65V-3.6V V_{CC} supply operation
- 3.6V tolerant inputs and outputs
- ton

3.0 ns max for 3.0V to 3.6V $\rm V_{CC}$ 3.9 ns max for 2.3V to 2.7V $\rm V_{CC}$ 7.8 ns max for 1.65V to 1.95V $\rm V_{CC}$

- Power-off high impedance inputs and outputs
- Supports live insertion and withdrawal (Note 1)
- Static Drive (I_{OH}/I_{OL}) ±24 mA @ 3.0V V_{CC}
 - ±18 mA @ 2.3V V_{CC}
 - ± 6 mA @ 1.65V V_{CC}
- Uses patented noise/EMI reduction circuitry
- Latch-up performance exceeds 300 mA
- ESD performance:

Human body model > 2000V

Machine model > 200V

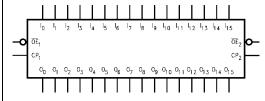
Note 1: To ensure the high-impedance state during power up or power down, $\overline{\text{DE}}$ should be tied to V_{CC} through a pull-up resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

Ordering Code:

Order Number	Package Number	Package Descriptions
74VCX16374MTD	MTD48	48-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide

Devices also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code

Logic Symbol



Pin Descriptions

Pin Names	Description
ŌEn	Output Enable Input (Active LOW)
CP _n	Clock Pulse Input
I ₀ -I ₁₅	Inputs
O ₀ -O ₁₅	Outputs

Connection Diagram

0E ₁ —	١,	\bigcirc	48	— CP1
	l		47	
o ₀ —	2			— _{1₀}
01 —	3		46	ا <u>-</u> ا
GND -	4		45	— GNE
02 —	5		44	— I ₂
03 -	6		43	— I ₃
v _{cc} -	7		42	— v _{cc}
04 -	8		41	— I₄
05 -	9		40	— I ₅
GND —	10		39	— GND
o ₆ —	11		38	— I ₆
07 —	12		37	— I ₇
08 —	13		36	— I ₈
o ₉ —	14		35	وا 🗕
GND -	15		34	— GND
010 -	16		33	- I ₁₀
011 -	17		32	— ا _{ا ۱}
v _{cc} —	18		31	- v _{cc}
012 -	19		30	- I ₁₂
013 —	20		29	— I _{1 3}
GND —	21		28	— GNE
014 —	22		27	— I₁₄
015 -	23		26	— I ₁₅
OE ₂	24		25	- CP2
-				ĺ

Truth Tables

	Inputs		Outputs
CP ₁	OE ₁	I ₀ –I ₇	00-07
~	L	Н	Н
~	L	L	L
L	L	X	O ₀
Х	Н	Χ	Z

	Inputs		Outputs
CP ₂	OE ₂	I ₈ –I ₁₅	O ₈ -O ₁₅
~	L	Н	Н
~	L	L	L
L	L	Х	O_0
Х	Н	Х	Z

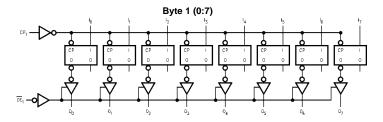
- H = HIGH Voltage Level
- = LOW Voltage Level
- = Immaterial (HIGH or LOW, inputs may not float)
- Z = High Impedance $O_0 = Previous O_0$ before HIGH-to-LOW of CP

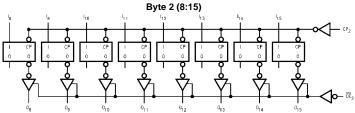
Functional Description

The 74VCX16374 consists of sixteen edge-triggered flipflops with individual D-type inputs and 3-STATE true outputs. The device is byte controlled with each byte functioning identically, but independent of the other. The control pins can be shorted together to obtain full 16-bit operation. Each clock has a buffered clock and buffered Output Enable common to all flip-flops within that byte. The description which follows applies to each byte. Each flip-

flop will store the state of their individual I inputs that meet the setup and hold time requirements on the LOW-to-HIGH Clock (\dot{CP}_n) transition. With the Output Enable (\overline{OE}_n) LOW, the contents of the flip-flops are available at the outputs. When \overline{OE}_n is HIGH, the outputs go to the high impedance state. Operations of the \overline{OE}_n input does not affect the state of the flip-flops.

Logic Diagram





Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings(Note 2)

 $\begin{array}{lll} \mbox{Supply Voltage (V_{CC})} & -0.5 \mbox{V to } +4.6 \mbox{V} \\ \mbox{DC Input Voltage (V_I)} & -0.5 \mbox{V to } +4.6 \mbox{V} \\ \end{array}$

Output Voltage (V_O)

Outputs 3-STATED -0.5V to +4.6V Outputs Active (Note 3) -0.5V to V_{CC} +0.5V DC Input Diode Current (I_{IK}) V_I < 0V -50 mA

DC Output Diode Current (I_{OK})

 $V_{O} < 0V$ —50 mA $V_{O} > V_{CC}$ +50 mA

DC Output Source/Sink Current

 (I_{OH}/I_{OL}) ±50 mA

DC V_{CC} or GND Current per

Supply Pin (I $_{CC}$ or GND) ± 100 mA

Storage Temperature Range (T $_{STG}$) $-65^{\circ}C$ to $+150^{\circ}C$

Recommended Operating Conditions (Note 4)

Power Supply

 Operating
 1.65V to 3.6V

 Data Retention Only
 1.2V to 3.6V

 Input Voltage
 -0.3V to +3.6V

Output Voltage (V_O)

Output in Active States 0V to V_{CC} Output in "OFF" State 0.0V to 3.6V

Output Current in I_{OH}/I_{OL}

 $\begin{array}{c} \text{V}_{\text{CC}} = 3.0 \text{V to } 3.6 \text{V} & \pm 24 \text{ mA} \\ \text{V}_{\text{CC}} = 2.3 \text{V to } 2.7 \text{V} & \pm 18 \text{ mA} \\ \text{V}_{\text{CC}} = 1.65 \text{V to } 2.3 \text{V} & \pm 6 \text{ mA} \\ \end{array}$ Free Air Operating Temperature (T_A) -40°C to $+85^{\circ}\text{C}$

Minimum Input Edge Rate (Δt/ΔV)

 $V_{IN} = 0.8V$ to 2.0V, $V_{CC} = 3.0V$ 10 ns/V

Note 2: The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the Absolute Maximum Ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 3: IO Absolute Maximum Rating must be observed.

Note 4: Floating or unused inputs must be held HIGH or LOW.

DC Electrical Characteristics (2.7V < $V_{\mbox{\footnotesize CC}} \leq$ 3.6V)

Symbol	Parameter	Conditions	V _{CC} (V)	Min	Max	Units
V _{IH}	HIGH Level Input Voltage		2.7 – 3.6	2.0		V
V_{IL}	LOW Level Input Voltage		2.7 – 3.6		0.8	V
V _{OH}	HIGH Level Output Voltage	$I_{OH} = -100 \mu A$	2.7 – 3.6	V _{CC} - 0.2		V
		I _{OH} = -12 mA	2.7	2.2		V
		$I_{OH} = -18 \text{ mA}$	3.0	2.4		V
		$I_{OH} = -24 \text{ mA}$	3.0	2.2		V
V _{OL}	LOW Level Output Voltage	$I_{OL} = 100 \mu A$	2.7 – 3.6		0.2	V
		I _{OL} = 12 mA	2.7		0.4	V
		I _{OL} = 18 mA	3.0		0.4	V
		I _{OL} = 24 mA	3.0		0.55	V
I _I	Input Leakage Current	$0 \le V_I \le 3.6V$	2.7 – 3.6		±5.0	μΑ
I _{OZ}	3-STATE Output Leakage	$0 \le V_O \le 3.6V$	2.7 – 3.6		±10	
		$V_I = V_{IH}$ or V_{IL}	2.7 - 3.6		±10	μΑ
I _{OFF}	Power-OFF Leakage Current	$0 \le (V_I, V_O) \le 3.6V$	0		10	μΑ
I _{CC}	Quiescent Supply Current	$V_I = V_{CC}$ or GND	2.7 – 3.6		20	μΑ
		$V_{CC} \le (V_I, V_O) \le 3.6V \text{ (Note 5)}$	2.7 – 3.6		±20	μΑ
ΔI_{CC}	Increase in I _{CC} per Input	$V_{IH} = V_{CC} - 0.6V$	2.7 – 3.6		750	μΑ

Note 5: Outputs disabled or 3-STATE only.

DC Electrical Characteristics (2.3V \leq $V_{CC} \leq$ 2.7V)

Symbol	Parameter	Conditions	(V)	Min	Max	Units
V _{IH}	HIGH Level Input Voltage		2.3 – 2.7	1.6		V
V _{IL}	LOW Level Input Voltage		2.3 – 2.7		0.7	V
V _{OH}	HIGH Level Output Voltage	$I_{OH} = -100 \mu A$	2.3 – 2.7	V _{CC} - 0.2		V
		$I_{OH} = -6 \text{ mA}$	2.3	2.0		V
		$I_{OH} = -12 \text{ mA}$	2.3	1.8		V
		$I_{OH} = -18 \text{ mA}$	2.3	1.7		V
V _{OL}	LOW Level Output Voltage	I _{OL} = 100 μA	2.3 – 2.7		0.2	V
		I _{OL} = 12 mA	2.3		0.4	V
		I _{OL} = 18 mA	2.3		0.6	V
I	Input Leakage Current	$0 \le V_I \le 3.6V$	2.3 – 2.7		±5.0	μΑ
I _{OZ}	3-STATE Output Leakage	0 ≤ V _O ≤ 3.6V	2.3 – 2.7		±10	μА
		$V_I = V_{IH}$ or V_{IL}	2.5 – 2.7		±10	μΑ
I _{OFF}	Power-OFF Leakage Current	$0 \le (V_I, V_O) \le 3.6V$	0		10	μΑ
I _{CC}	Quiescent Supply Current	$V_I = V_{CC}$ or GND	2.3 – 2.7		20	μΑ
		$V_{CC} \le (V_I, V_O) \le 3.6V \text{ (Note 6)}$	2.3 – 2.7		±20	μΑ

Note 6: Outputs disabled or 3-STATE only.

DC Electrical Characteristics (1.65V \leq $V_{\mbox{\footnotesize CC}} <$ 2.3V)

Symbol	Parameter	Conditions	V _{CC} (V)	Min	Max	Units
V _{IH}	HIGH Level Input Voltage		1.65 - 2.3	$0.65 \times V_{CC}$		V
V _{IL}	LOW Level Input Voltage		1.65 - 2.3		$0.35 \times V_{CC}$	V
V _{OH}	HIGH Level Output Voltage	$I_{OH} = -100 \mu A$	1.65 - 2.3	V _{CC} - 0.2		V
		$I_{OH} = -6 \text{ mA}$	1.65	1.25		V
V _{OL}	LOW Level Output Voltage	I _{OL} = 100 μA	1.65 - 2.3		0.2	V
		I _{OL} = 6 mA	1.65		0.3	V
II	Input Leakage Current	$0 \le V_1 \le 3.6V$	1.65 - 2.3		±5.0	μΑ
I _{OZ}	3-STATE Output Leakage	$0 \le V_O \le 3.6V$ $V_I = V_{IH} \text{ or } V_{II}$	1.65 - 2.3		±10	μА
I _{OFF}	Power-OFF Leakage Current	$0 \le (V_1, V_0) \le 3.6V$	0		10	μА
I _{CC}	Quiescent Supply Current	V _I = V _{CC} or GND	1.65 - 2.3		20	μΑ
		$V_{CC} \le (V_I, V_O) \le 3.6V \text{ (Note 7)}$	1.65 - 2.3		±20	μΑ

Note 7: Outputs disabled or 3-STATE only.

AC Electrical Characteristics (Note 8)

			$T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$, $C_L = 30$ pF, $R_L = 500\Omega$					
Symbol	Parameter	V _{CC} = 3.	.3V ± 0.3V	V _{CC} = 2.	.5V ± 0.2V	V _{CC} = 1.8	3V ± 0.15V	Units
		Min	Max	Min	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency	250		200		100		MHz
t _{PHL} , t _{PLH}	Prop Delay CP to O _n	0.8	3.0	1.0	3.9	1.5	7.8	ns
t _{PZL} , t _{PZH}	Output Enable Time	0.8	3.5	1.0	4.6	1.5	9.2	ns
t _{PLZ} , t _{PHZ}	Output Disable Time	0.8	3.5	1.0	3.8	1.5	6.8	ns
t _S	Setup Time	1.5		1.5		2.5		ns
t _H	Hold Time	1.0		1.0		1.0		ns
t _W	Pulse Width	1.5		1.5		4.0		ns
t _{OSHL}	Output to Output Skew (Note 9)		0.5		0.5		0.75	ns
toslh	(Note 9)							

Note 8: For $C_L = 50_P F$, add approximately 300 ps to the AC maximum specification.

Note 9: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}).

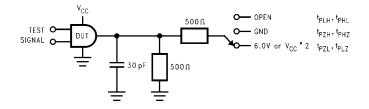
Dynamic Switching Characteristics

Symbol	Parameter	Conditions	V _{CC} (V)	T _A = +25°C	Units
V _{OLP}	Quiet Output Dynamic Peak V _{OL}	$C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0V$	1.8	0.25	
			2.5	0.6	V
			3.3	0.8	
V _{OLV}	Quiet Output Dynamic Valley V _{OL}	$C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0V$	1.8	-0.25	
			2.5	-0.6	V
			3.3	-0.8	
V _{OHV}	Quiet Output Dynamic Valley VOH	$C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0V$	1.8	1.5	
			2.5	1.9	V
			3.3	2.2	

Capacitance

Symbol	Parameter	Conditions	$T_A = +25^{\circ}C$	Units
Oyinboi	i arameter	Conditions	Typical	
C _{IN}	Input Capacitance	$V_{CC} = 1.8V$, 2.5V or 3.3V, $V_{I} = 0V$ or V_{CC}	6	pF
C _{OUT}	Output Capacitance	$V_I = 0V \text{ or } V_{CC}, V_{CC} = 1.8V, 2.5V \text{ or } 3.3V$	7	pF
C _{PD}	Power Dissipation Capacitance	$V_I = 0V \text{ or } V_{CC}, f = 10 \text{ MHz},$	20	pF
		V _{CC} = 1.8V, 2.5V or 3.3V	20	ы

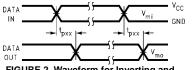
AC Loading and Waveforms



TEST	SWITCH
t_{PLH}, t_{PHL}	Open
t _{PZL} , t _{PLZ}	6V at $V_{CC} = 3.3 \pm 0.3V$; $V_{CC} \times 2$ at $V_{CC} = 2.5 \pm 0.2V$; $1.8V \pm 0.15V$
t_{PZH},t_{PHZ}	GND

FIGURE 1. AC Test Circuit

OUTPUT



CONTROL DATA FIGURE 3. 3-STATE Output High Enable and

FIGURE 2. Waveform for Inverting and **Non-Inverting Functions**

Disable Times for Low Voltage Logic

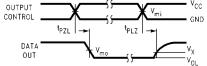
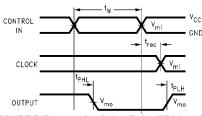


FIGURE 4. 3-STATE Output Low Enable and Disable Times for Low Voltage Logic



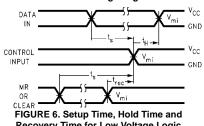
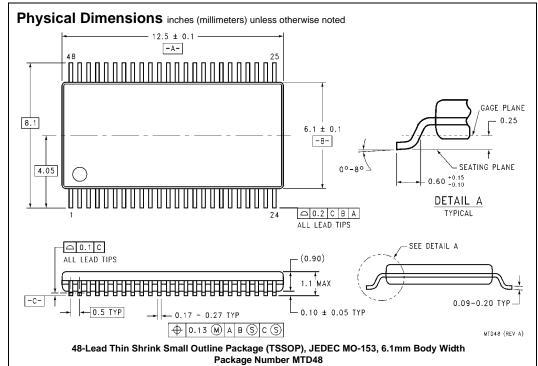


FIGURE 5. Propagation Delay, Pulse Width and t_{rec} Waveforms

Recovery Time for Low Voltage Logic

Symbol	V _{CC}		
	$3.3V \pm 0.3V$	2.5V ± 0.2V	1.8V ± 0.15V
V _{mi}	1.5V	V _{CC} /2	V _{CC} /2
V _{mo}	1.5V	V _{CC} /2	V _{CC} /2
V _X	V _{OL} +0.3V	V _{OL} +0.15V	V _{OL} +0.15V
V _Y	V _{OH} −0.3V	V _{OH} -0.15V	V _{OH} -0.15V



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